

2SK2926(L), 2SK2926(S)

Silicon N Channel MOS FET
High Speed Power Switching

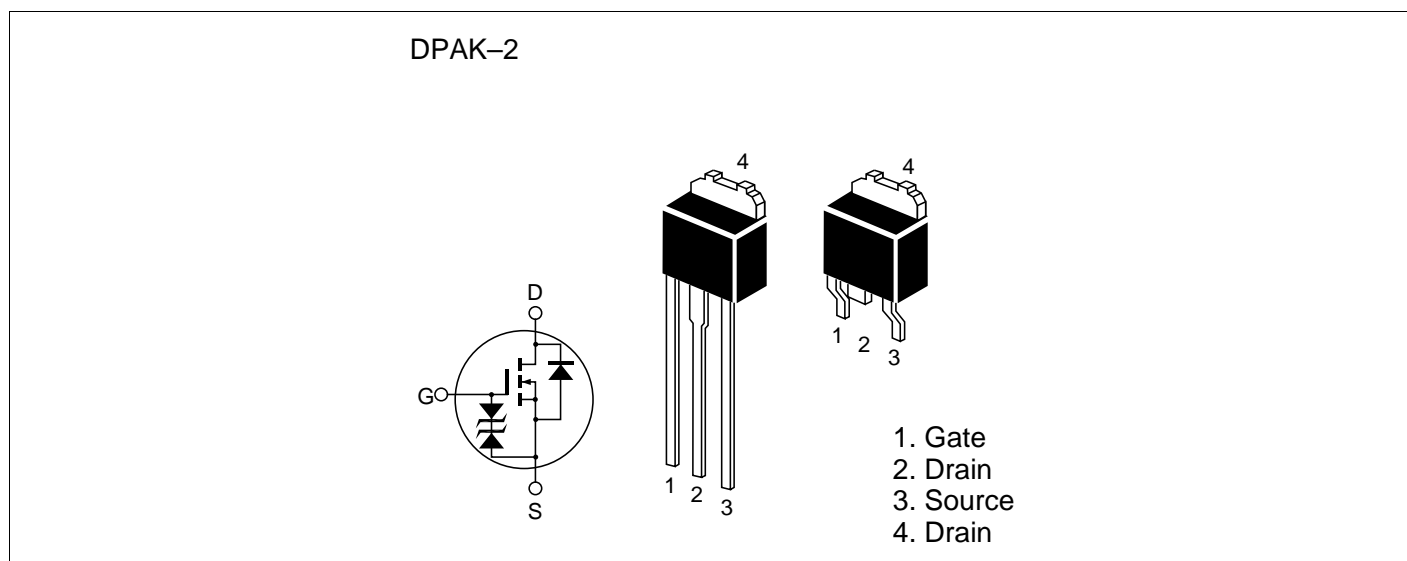
HITACHI

ADE-208-535
1st. Edition

Features

- Low on-resistance
 $R_{DS(on)} = 0.042\Omega$ typ.
- 4V gate drive devices.
- High speed switching

Outline



2SK2926(L), 2SK2926(S)

Absolute Maximum Ratings (Ta = 25°C)

| Item | Symbol | Ratings | Unit |
|---|---------------------|-------------|------|
| Drain to source voltage | V_{DSS} | 60 | V |
| Gate to source voltage | V_{GSS} | ±20 | V |
| Drain current | I_D | 15 | A |
| Drain peak current | $I_{D(pulse)}^{*1}$ | 60 | A |
| Body to drain diode reverse drain current | I_{DR} | 15 | A |
| Avalanche current | I_{AP}^{*3} | 15 | A |
| Avalanche energy | E_{AR}^{*3} | 19 | mJ |
| Channel dissipation | Pch^{*2} | 25 | W |
| Channel temperature | Tch | 150 | °C |
| Storage temperature | Tstg | -55 to +150 | °C |

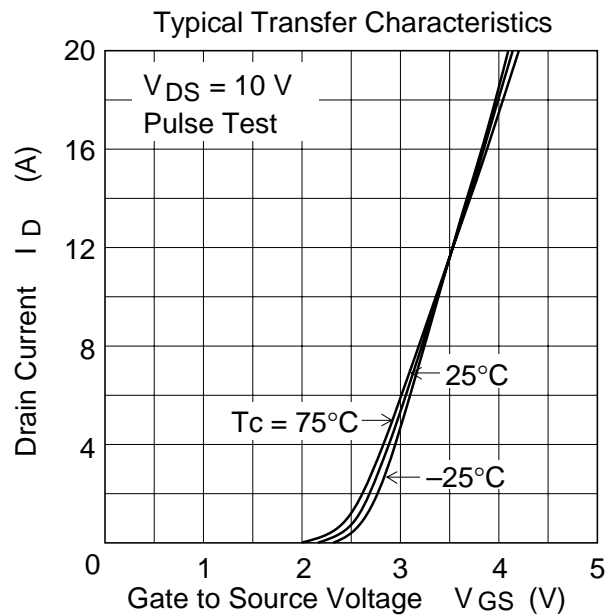
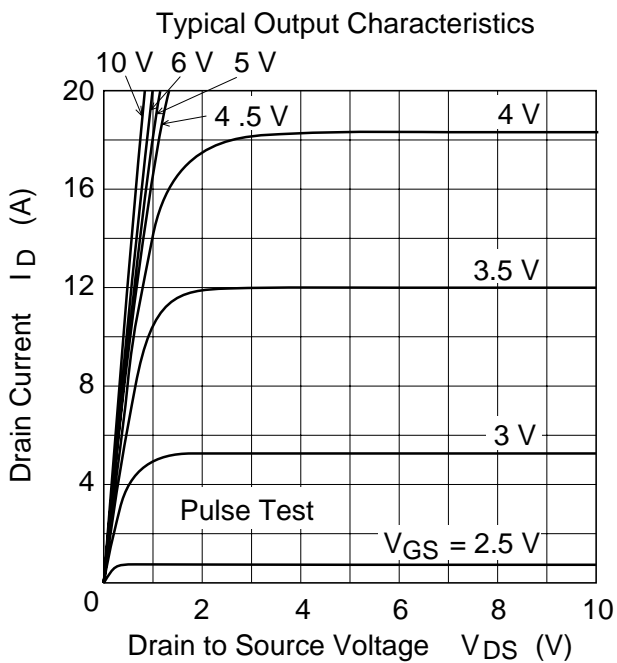
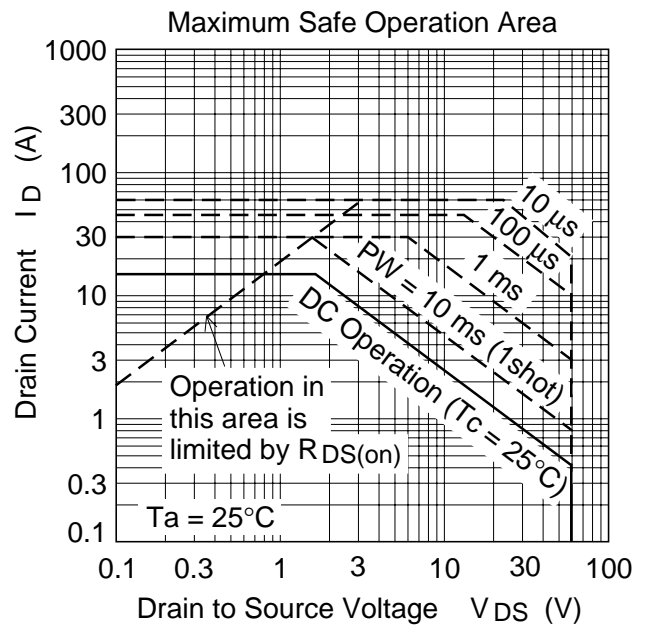
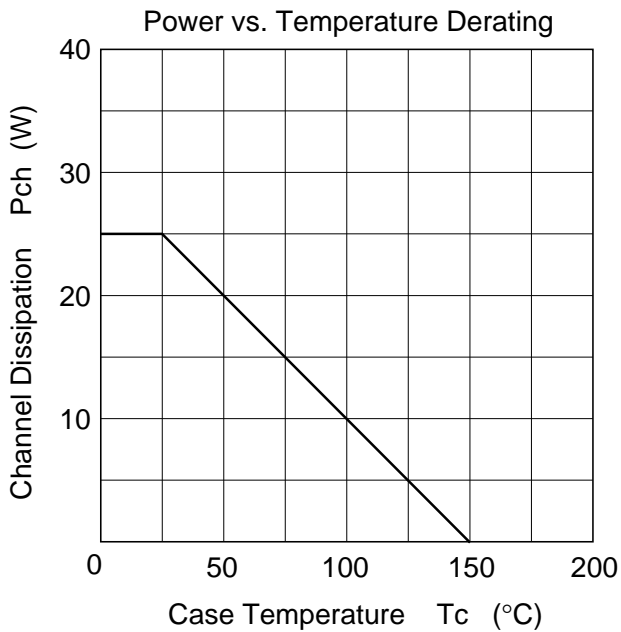
- Notes: 1. $PW \leq 10\mu s$, duty cycle $\leq 1\%$
2. Value at Ta = 25°C
3. Value at Ta = 25°C, Rg $\geq 50\ \Omega$

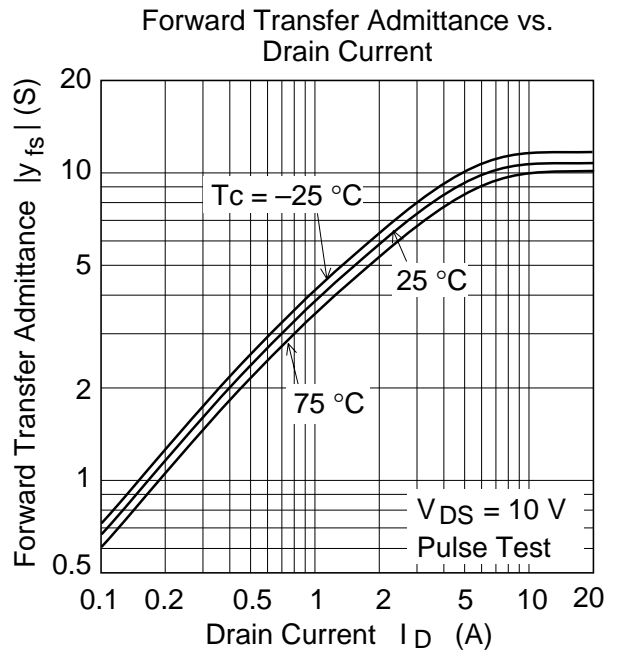
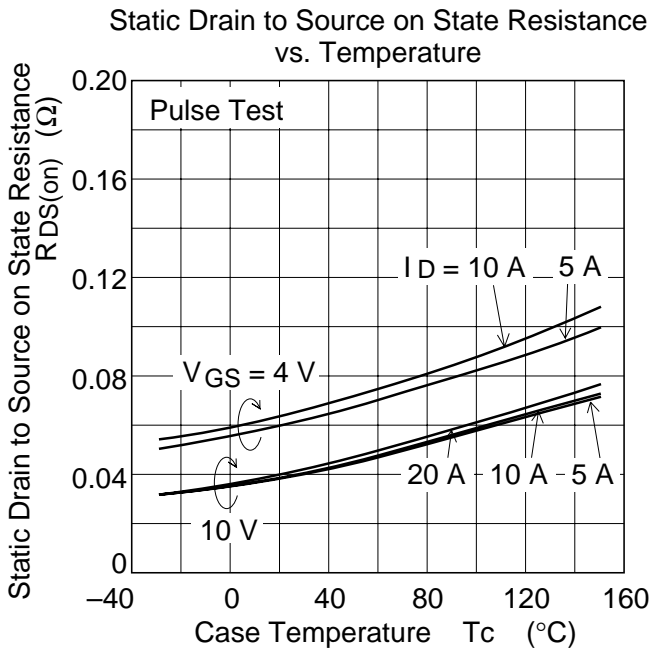
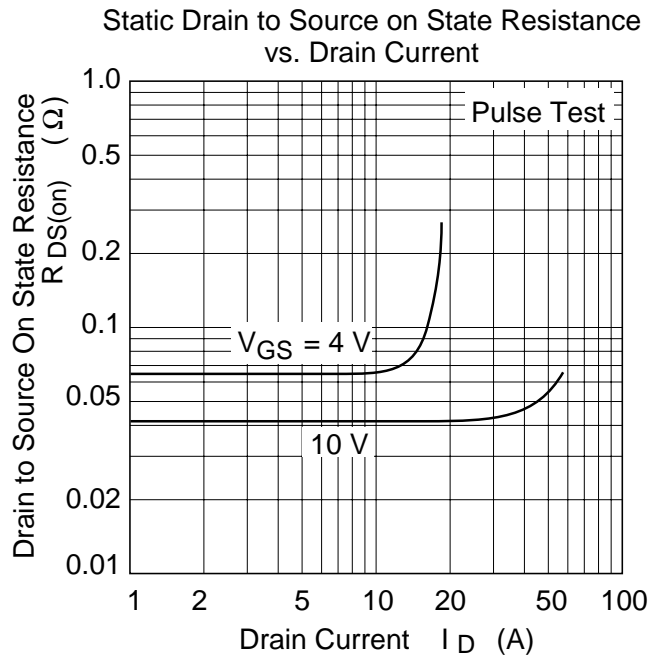
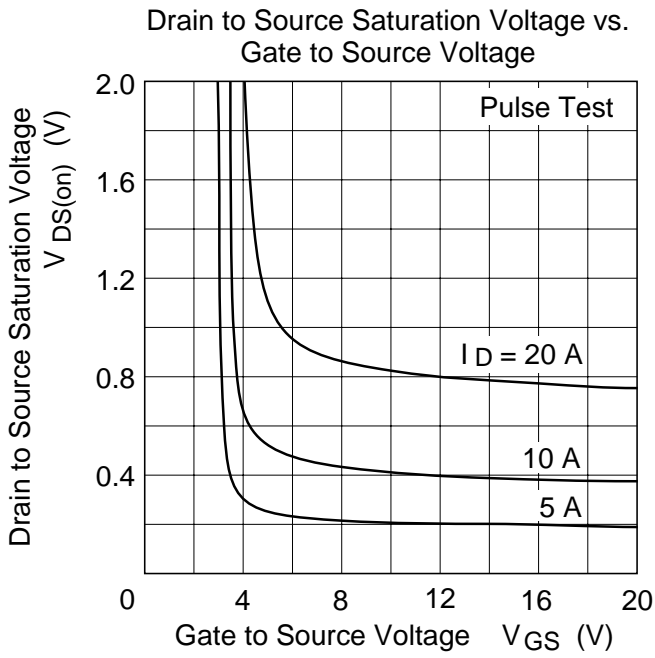
Electrical Characteristics (Ta = 25°C)

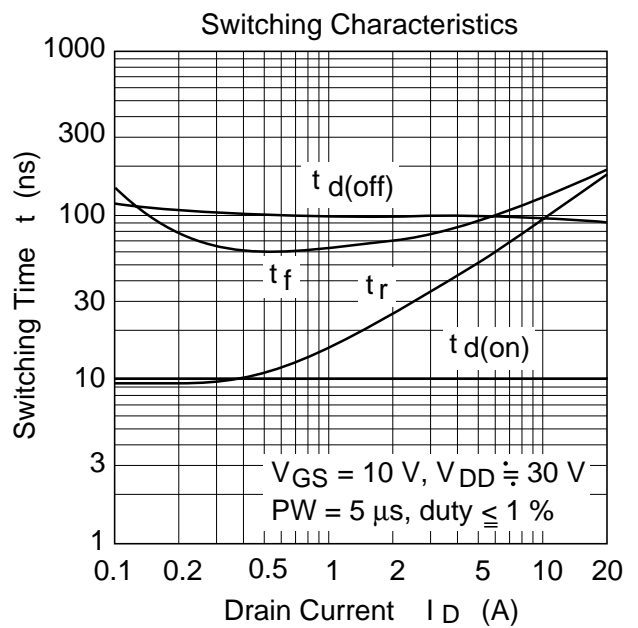
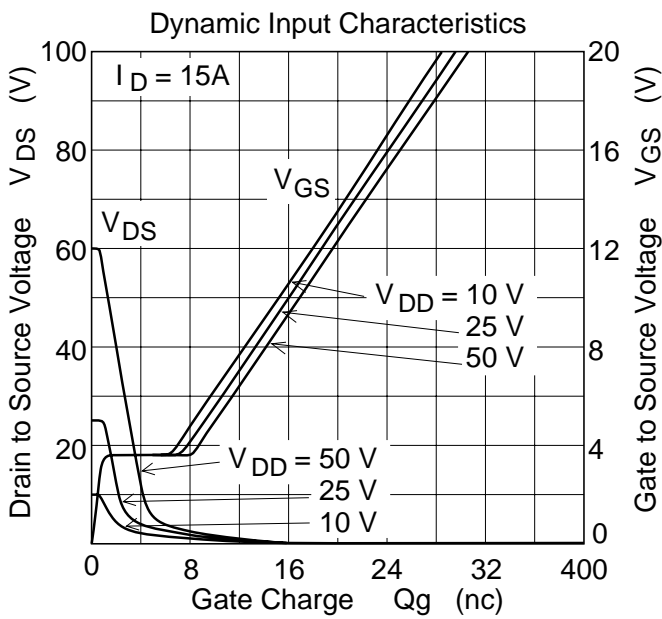
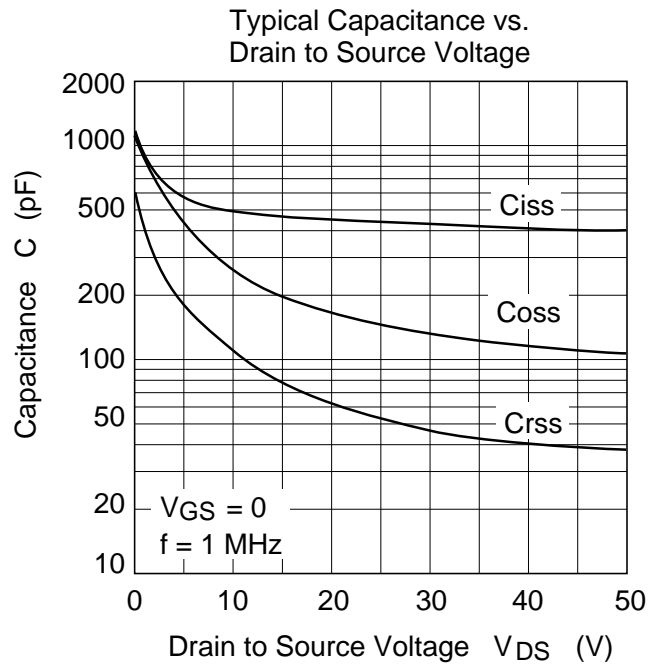
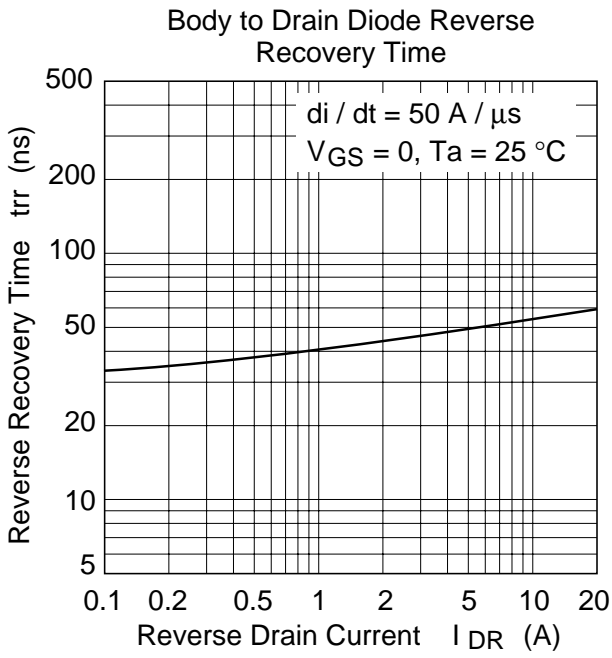
| Item | Symbol | Min | Typ | Max | Unit | Test Conditions |
|--|---------------|----------|-------|----------|---------------|--|
| Drain to source breakdown voltage | $V_{(BR)DSS}$ | 60 | — | — | V | $I_D = 10\text{mA}, V_{GS} = 0$ |
| Gate to source breakdown voltage | $V_{(BR)GSS}$ | ± 20 | — | — | V | $I_G = \pm 100\mu\text{A}, V_{DS} = 0$ |
| Zero gate voltage drain current | I_{DSS} | — | — | 10 | μA | $V_{DS} = 60\text{V}, V_{GS} = 0$ |
| Gate to source leak current | I_{GSS} | — | — | ± 10 | μA | $V_{GS} = \pm 16\text{V}, V_{DS} = 0$ |
| Gate to source cutoff voltage | $V_{GS(off)}$ | 1.5 | — | 2.5 | V | $I_D = 1\text{mA}, V_{DS} = 10\text{V}$ |
| Static drain to source on state resistance | $R_{DS(on)}$ | — | 0.042 | 0.055 | Ω | $I_D = 8\text{A}, V_{GS} = 10\text{V}^{*1}$ |
| | $R_{DS(on)}$ | — | 0.065 | 0.11 | Ω | $I_D = 8\text{A}, V_{GS} = 4\text{V}^{*1}$ |
| Forward transfer admittance | $ y_{fs} $ | 7 | 11 | — | S | $I_D = 8\text{A}, V_{DS} = 10\text{V}^{*1}$ |
| Input capacitance | C_{iss} | — | 500 | — | pF | $V_{DS} = 10\text{V}$ |
| Output capacitance | C_{oss} | — | 260 | — | pF | $V_{GS} = 0$ |
| Reverse transfer capacitance | C_{rss} | — | 110 | — | pF | $f = 1\text{MHz}$ |
| Turn-on delay time | $t_{d(on)}$ | — | 10 | — | ns | $V_{GS} = 10\text{V}, I_D = 8\text{A}$ |
| Rise time | t_r | — | 80 | — | ns | $R_L = 3.75\Omega$ |
| Turn-off delay time | $t_{d(off)}$ | — | 100 | — | ns | |
| Fall time | t_f | — | 110 | — | ns | |
| Body to drain diode forward voltage | V_{DF} | — | 1.0 | — | V | $I_F = 15\text{A}, V_{GS} = 0$ |
| Body to drain diode reverse recovery time | t_{rr} | — | 55 | — | ns | $I_F = 15\text{A}, V_{GS} = 0$ $di_F/dt = 50\text{A}/\mu\text{s}$ |

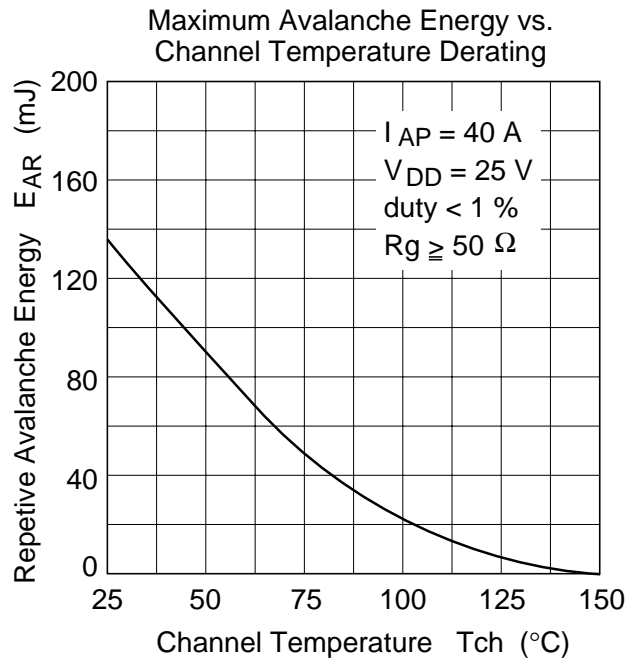
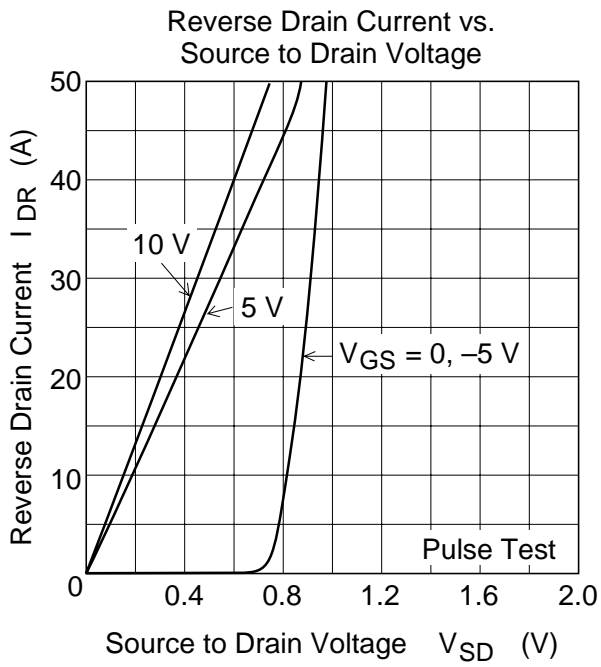
Note: 1. Pulse test

Main Characteristics

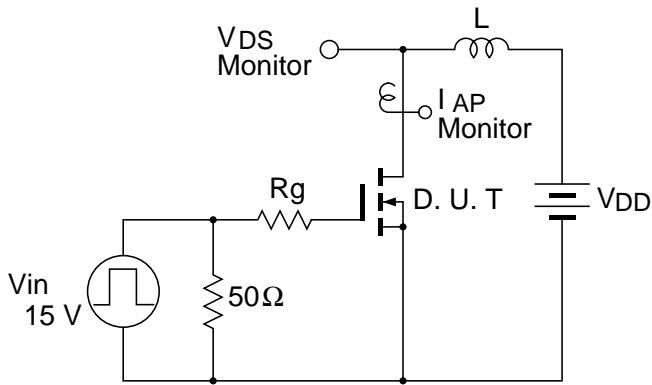






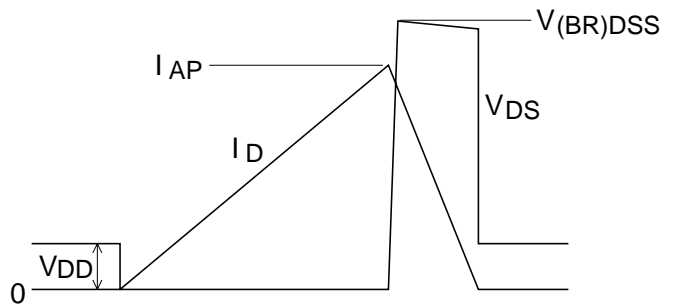


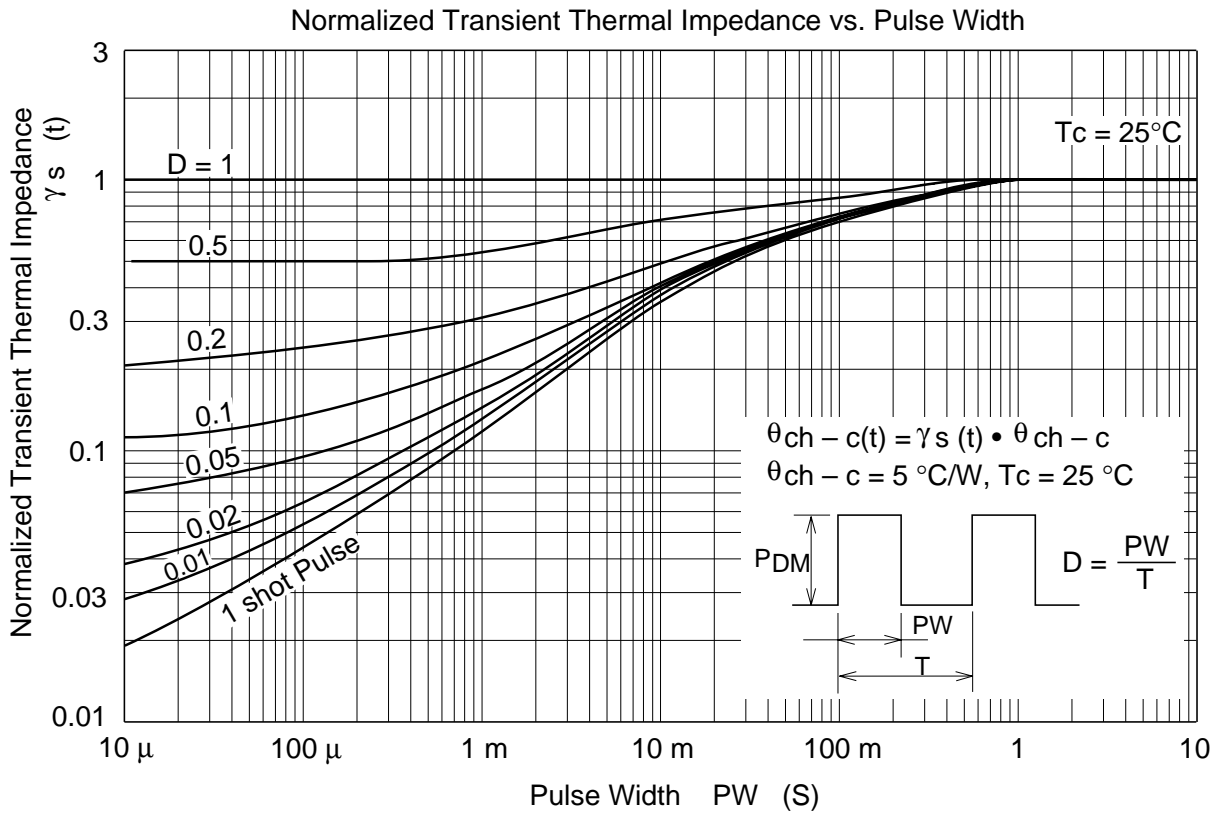
Avalanche Test Circuit



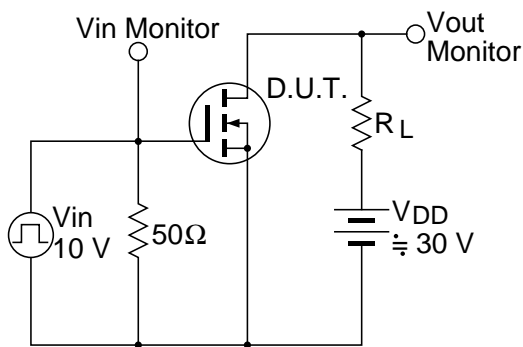
Avalanche Waveform

$$E_{AR} = \frac{1}{2} \cdot L \cdot I_{AP}^2 \cdot \frac{V_{DSS}}{V_{DSS} - V_{DD}}$$

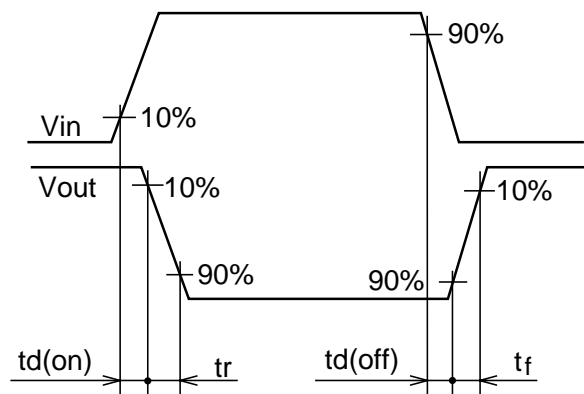




Switching Time Test Circuit

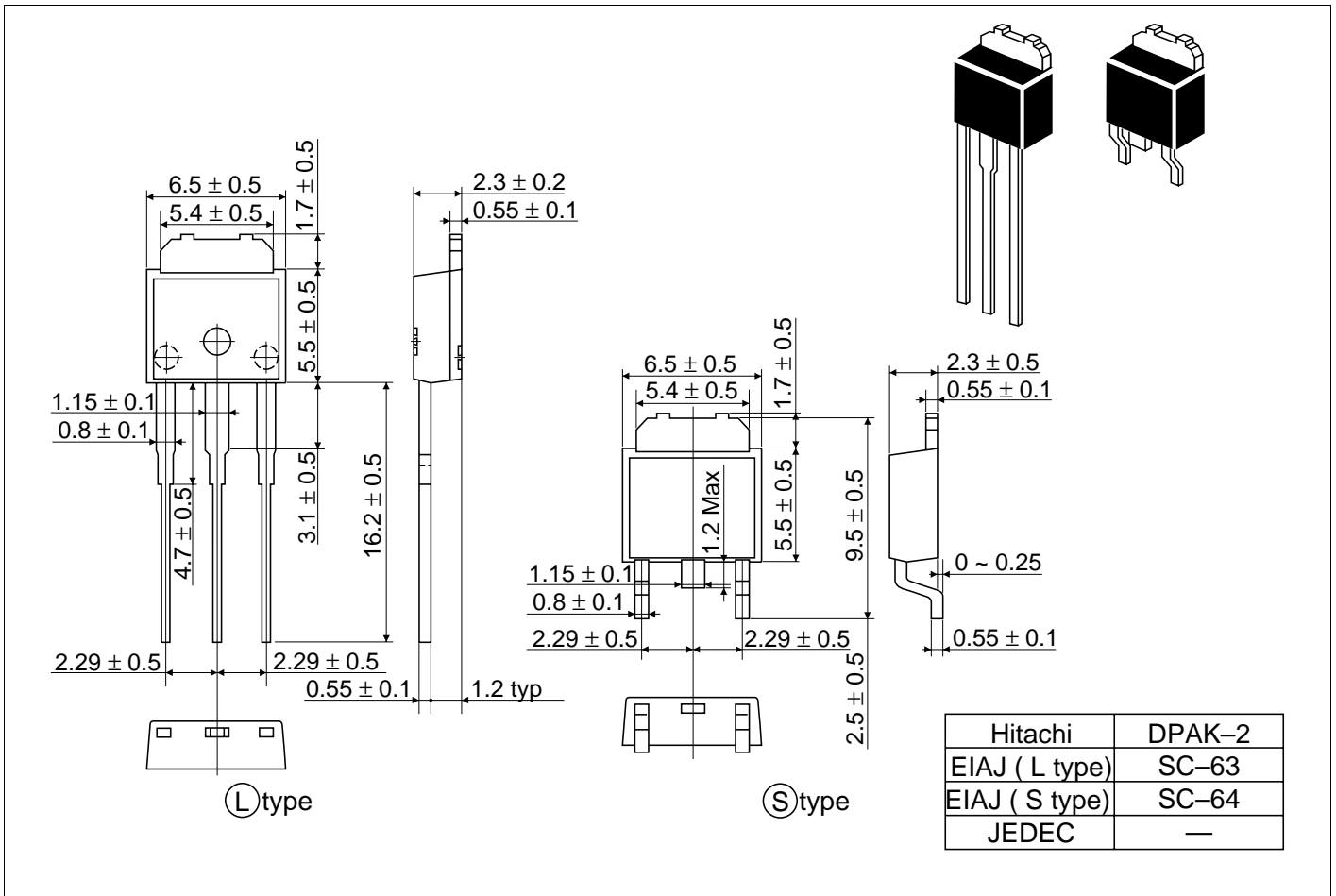


Switching Time Waveform



Package Dimensions

Unit: mm



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